

Application No.	Applicant(s)	_
10/721,920	AHN ET AL.	
Examiner	Art Unit	
Michael Trinh	2822	

	SEARCHED			
Class	Subclass	Date	Examiner	
438	649	12/12/2004	МТ	
438	655	12/12/2004	MT	
438	653	12/12/2004	MT	
438	652	12/12/2004	МТ	
438	624	12/12/2004	МТ	
438	623	12/12/2004	МТ	
438	619	12/12/2004	МТ	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	55, 653, 624 23,619	12/13/2004	МТ		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Databases: USPAT, JPO, PG-PUB, EPO	12/12/2004	МТ		
Checked parent application 09584,157, now Patent No. 6,674,167.	12/12/2004	МТ		
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